

Notice of References Cited	Application/Control No. 10/809,920	Applicant(s)/Patent Under Reexamination STENDEL ET AL.	
	Examiner S. TRAN	Art Unit 1615	Page 1 of 1

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*	A	US-5,749,895	05-1998	Sawyer et al.	606/214
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	I	US-			
	J	US-			
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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